Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/541,230	GERHARTZ ET AL.	
Examiner	Art Unit	_
David W. Scheuermann	2834	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
J. Jones	4/26	DS		
L Donovan	4/29	23		
B. Mullins Allowable Come		DS		